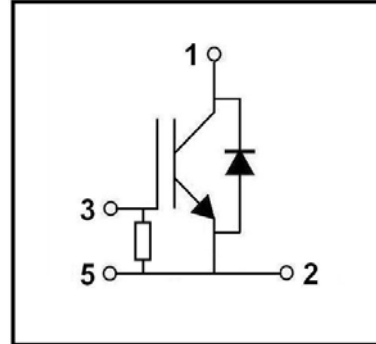


FEATURES

- Ultra Low Loss
- High Ruggedness
- High Short Circuit Capability
- Positive Temperature Coefficient
- With Fast Free-Wheeling Diodes
- 10K Ω Gate Protected Resistance Inside

APPLICATIONS

- Inverter
- Convertor
- Welder
- SMPS and UPS
- Induction Heating



ABSOLUTE MAXIMUM RATINGS

$T_C=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Test Conditions	Values	Unit
IGBT				
V_{CES}	Collector - Emitter Voltage		1200	V
V_{GES}	Gate - Emitter Voltage		± 20	V
I_C	DC Collector Current	$T_C=25^\circ\text{C}$	900	A
		$T_C=80^\circ\text{C}$	600	A
I_{Cpuls}	Pulsed Collector Current	$T_C=25^\circ\text{C}, t_p=1\text{ms}$	1800	A
		$T_C=80^\circ\text{C}, t_p=1\text{ms}$	1200	A
P_{tot}	Power Dissipation Per IGBT		2800	W
T_J	Junction Temperature Range		-40 to +150	$^\circ\text{C}$
T_{STG}	Storage Temperature Range		-40 to +125	$^\circ\text{C}$
V_{isol}	Insulation Test Voltage	AC, $t=1\text{min}$	3000	V
Free-Wheeling Diode				
V_{RRM}	Repetitive Reverse Voltage		1200	V
$I_{F(AV)}$	Average Forward Current	$T_C=25^\circ\text{C}$	600	A
		$T_C=80^\circ\text{C}$	400	A
$I_{F(RMS)}$	RMS Forward Current		600	A
I_{FSM}	Non-Repetitive Surge	$T_J=45^\circ\text{C}, t=10\text{ms}, \text{Sine}$	3800	A
	Forward Current	$T_J=45^\circ\text{C}, t=8.3\text{ms}, \text{Sine}$	4300	A

MMG600K120U6TN

ELECTRICAL CHARACTERISTICS

T_C=25°C unless otherwise specified

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
IGBT						
V _{GE(th)}	Gate - Emitter Threshold Voltage	V _{CE} =V _{GE} , I _C =24mA	5.0	5.8	6.5	V
V _{CE(sat)}	Collector - Emitter Saturation Voltage	I _C =600A, V _{GE} =15V, T _J =25°C		1.7		V
		I _C =600A, V _{GE} =15V, T _J =125°C		2.0		V
I _{CEs}	Collector Leakage Current	V _{CE} =1200V, V _{GE} =0V, T _J =25°C			5	mA
I _{GES}	Gate Leakage Current	V _{CE} =0V, V _{GE} =±20V			400	nA
R _{Gint}	Integrated Gate Resistor			1.3		Ω
Q _{ge}	Gate Charge	V _{CC} =600V, I _C =600A, V _{GE} =±15V		5600		nC
C _{ies}	Input Capacitance	V _{CE} =25V, V _{GE} =0V, f=1MHz		42		nF
C _{res}	Reverse Transfer Capacitance				1.7	
t _{d(on)}	Turn - on Delay Time	V _{CC} =600V, I _C =600A R _G =1.2 Ω, V _{GE} =±15V T _J =25°C Inductive Load		250		ns
t _r	Rise Time			90		ns
t _{d(off)}	Turn - off Delay Time			550		ns
t _f	Fall Time			130		ns
t _{d(on)}	Turn - on Delay Time	V _{CC} =600V, I _C =600A R _G =1.2 Ω, V _{GE} =±15V T _J =125°C Inductive Load		300		ns
t _r	Rise Time			100		ns
t _{d(off)}	Turn - off Delay Time			650		ns
t _f	Fall Time			180		ns
E _{on}	Turn - on Switching Energy	V _{CC} =600V, I _C =600A, T _J =25°C		33		mJ
		R _G =1.2 Ω, T _J =125°C		50		mJ
E _{off}	Turn - off Switching Energy	V _{GE} =±15V, T _J =25°C		58		mJ
		Inductive Load, T _J =125°C		88		mJ
Free-Wheeling Diode						
V _F	Forward Voltage	I _F =600A, V _{GE} =0V, T _J =25°C		1.65	2.15	V
		I _F =600A, V _{GE} =0V, T _J =125°C		1.65		V
I _{RRM}	Max. Reverse Recovery Current	I _F =600A, V _R =600V		540		A
Q _{rr}	Reverse Recovery Charge	di _F /dt=-5000A/μs		115		μC
E _{rec}	Reverse Recovery Charge	T _J =125°C		52.0		mJ

THERMAL AND MECHANICAL CHARACTERISTICS

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
R _{thJC}	Junction-to-Case Thermal Resistance	Per IGBT			0.045	K /W
R _{thJCD}	Junction-to-Case Thermal Resistance	Per Inverse Diode			0.08	K /W
Torque	Module-to-Sink	Recommended (M6)	3		5	N · m
Torque	Module Electrodes	Recommended (M6)	2.5		5	N · m
Torque	Module Electrodes	Recommended (M4)	0.7		1.1	N · m
Weight				325		g

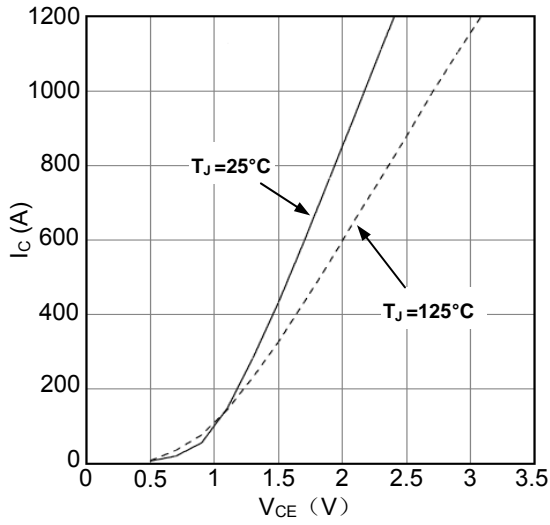


Figure1. Typical Output characteristics

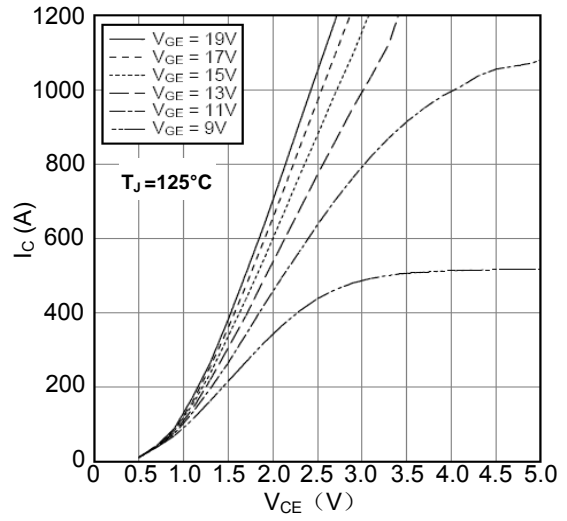


Figure2. Typical Output characteristics

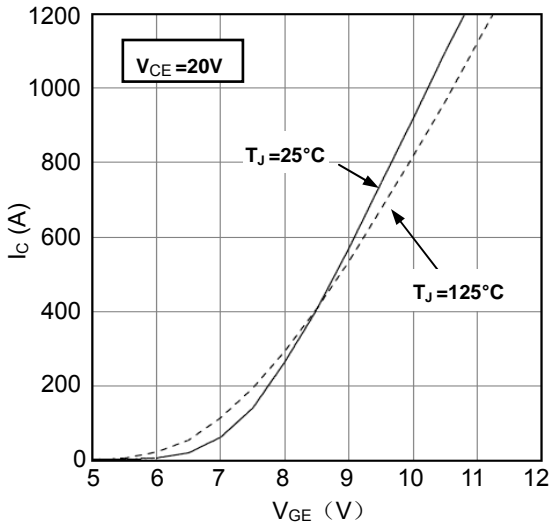


Figure3. Typical Transfer characteristics

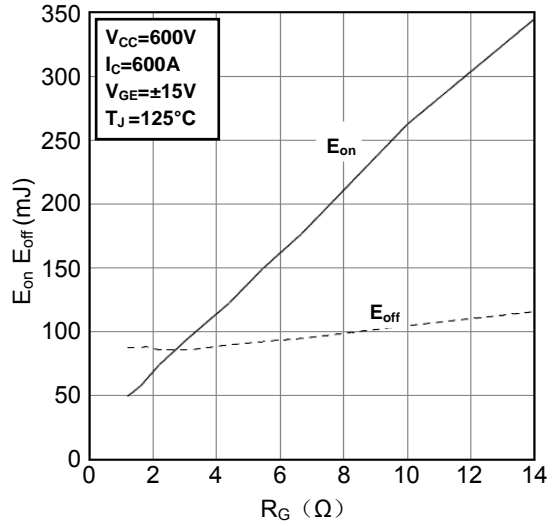


Figure4. Switching Energy vs. Gate Resistor

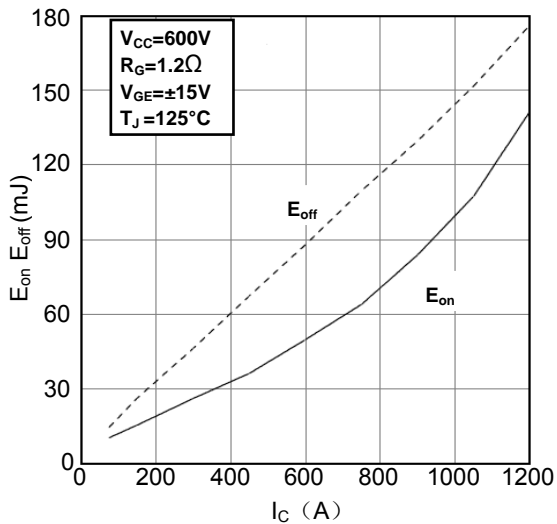


Figure5. Switching Energy vs. Collector Current

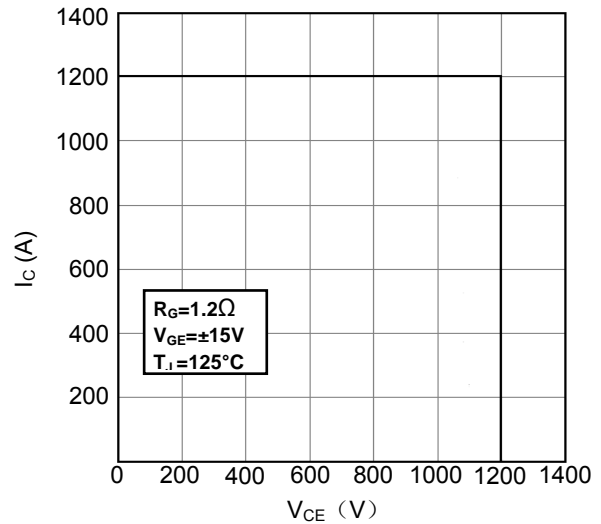


Figure6. Reverse Biased Safe Operating Area

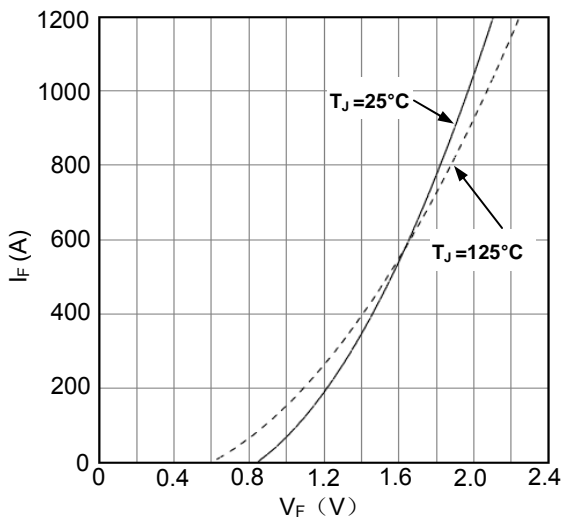


Figure 7. Diode Forward Characteristics

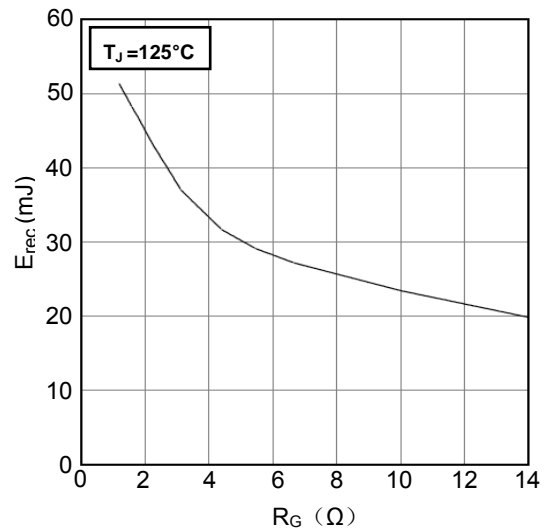


Figure 8. Switching Energy vs. Gate Resistor

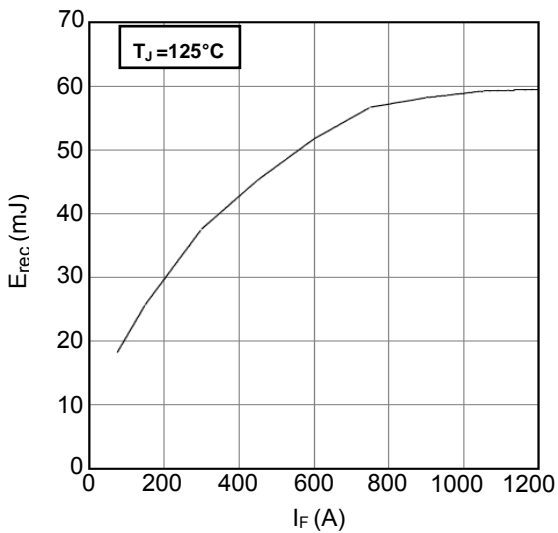


Figure 9. Switching Energy vs. Forward Current

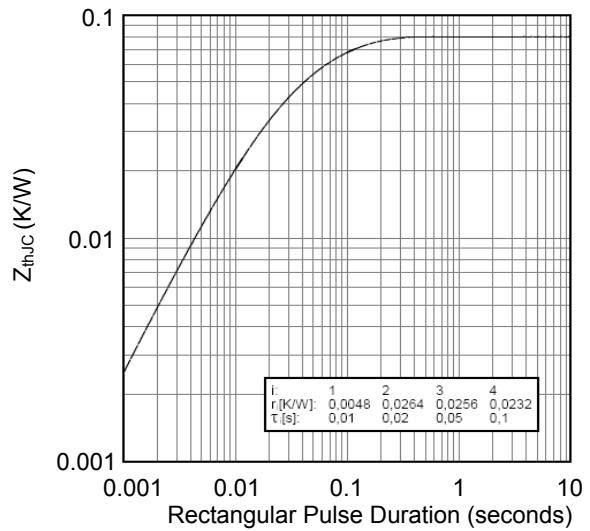


Figure 10. Transient Thermal Impedance of Diode

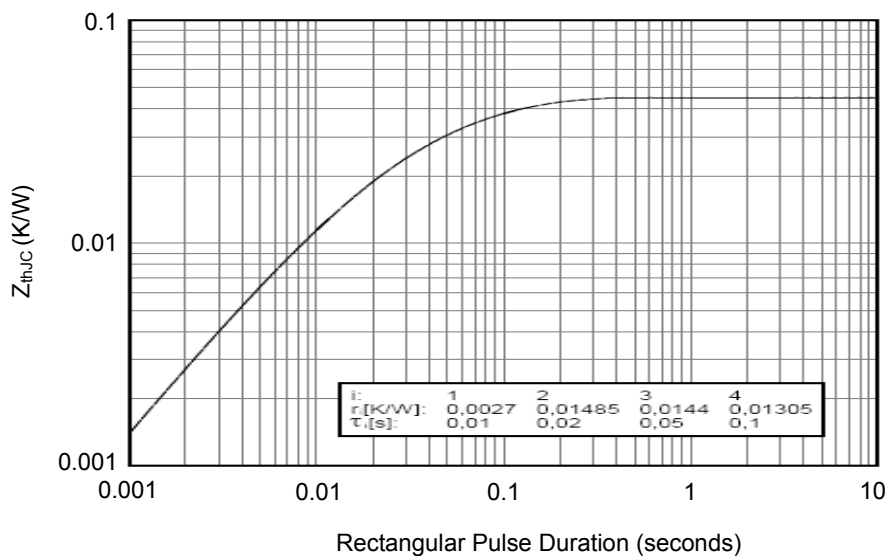


Figure 11. Transient Thermal Impedance of IGBT

